

Description

The IRF7807PBF uses advanced trench technology to provide excellent $R_{DS(ON)}$, low gate charge and operation with gate voltages as low as 4.5V. This device is suitable for use as a Battery protection or in other Switching application.

General Features

V_{DS} = 30V I_D =8.5A

 $R_{DS(ON)}$ < 18m Ω @ V_{GS}=10V

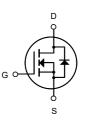
Application

Battery protection

Load switch Uninterruptible power supply



SOP-8



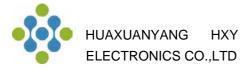
N-Channel MOSFET

Package Marking and Ordering Information

Product ID	Pack	Brand	Qty(PCS)
IRF7807PBF	SOP-8	HXY MOSFET	3000

Absolute Maximum Ratings (T_A = 25 $^\circ C$ unless otherwise noted)

Symbol	Parameter	Rating	Units	
Vds	Drain-Source Voltage	30	V	
Vgs	Gate-Source Voltage	Gate-Source Voltage ±20		
I _D @T _A =25°C	Continuous Drain Current ¹	Continuous Drain Current ¹ 8.5		
I _D @T _A =70°C	Continuous Drain Current ¹	Continuous Drain Current ¹ 5.6		
Ідм	Pulsed Drain Current ²	Pulsed Drain Current ² 35		
EAS	Single Pulse Avalanche Energy ³	e Pulse Avalanche Energy ³ 20		
las	Avalanche Current	Avalanche Current 20		
P _D @T _A =25°C	Total Power Dissipation ⁴	1.5	W	
Тѕтс	Storage Temperature Range	-55 to 150	°C	
TJ	Operating Junction Temperature Range	-55 to 150	°C	
	Thermal Resistance Junction-ambient¹(t≤10s)	85	°C/W	
R ₀ JA	Thermal Resistance Junction-ambient ¹	25	°C/W	



Symbol	Parameter	Conditions	Min.	Тур.	Max.	Unit	
BV _{DSS}	Drain-Source Breakdown Voltage	V _{GS} =0V , I _D =250uA	30			V	
$\triangle BV_{\text{DSS}} / \triangle T_{\text{J}}$	BVDSS Temperature Coefficient	Reference to 25°C,I₀=1mA		0.034		V/°C	
R _{DS(ON)}	Static Drain-Source On-Resistance ²	V _{GS} =10V , I _D =7A	14 18 20 26				
	Static Drain-Source On-Resistance-	V _{GS} =4.5V , I _D =4A			26	mΩ	
$V_{GS(th)}$	Gate Threshold Voltage		1.2	1.5	2.5	V	
$ riangle V_{GS(th)}$	V _{GS(th)} Temperature Coefficient	──V _{GS} =V _{DS} , I _D =250uA		-3.84		mV/°C	
	Drain-Source Leakage Current	V _{DS} =24V , V _{GS} =0V , T _J =25°C			1	uA	
IDSS		V _{DS} =24V , V _{GS} =0V , T _J =55°C			5		
lgss	Gate-Source Leakage Current	V _{GS} =±20V , V _{DS} =0V			±100	nA	
gfs	Forward Transconductance	V _{DS} =5V , I _D =7A		6.2		S	
R _g	Gate Resistance	V _{DS} =0V , V _{GS} =0V , f=1MHz		1.04	2.1	Ω	
Qg	Total Gate Charge (4.5V)			6	8.4		
Q _{gs}	Gate-Source Charge	V _{DS} =15V , V _{GS} =4.5V , I _D =7A		2.2	3.1	nC	
Q_{gd}	Gate-Drain Charge			2	2.8		
T _{d(on)}	Turn-On Delay Time			1.2	2.4		
Tr	Rise Time	V_{DD} =15V , V_{GS} =10V , R_G =3.3 Ω		40	72.0	- ns	
T _{d(off)}	Turn-Off Delay Time	I _D =7A		18	36.0		
T _f	Fall Time			7.2	14.4		
Ciss	Input Capacitance			583	816.2		
Coss	Output Capacitance	V _{DS} =15V , V _{GS} =0V , f=1MHz		77	107.8	pF	
C _{rss}	Reverse Transfer Capacitance			59	82.6		
ls	Continuous Source Current ^{1,5}				7	А	
lsм	Pulsed Source Current ^{2,5}	──V _G =V _D =0V , Force Current			35	Α	
V_{SD}	Diode Forward Voltage ²	V _{GS} =0V , I _S =1A , T _J =25°C			1.2	V	
t _{rr}	Reverse Recovery Time			7.2		nS	
Qrr	Reverse Recovery Charge	I⊧=7A , dI/dt=100A/µs , Tյ=25°C		2.9		nC	

Electrical Characteristics (TJ=25 °C, unless otherwise noted)

Note :

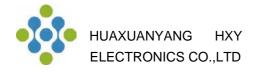
1. The data tested by surface mounted on a 1 inch² FR-4 board with 2OZ copper.

2.The data tested by pulsed , pulse width \leq 300us , duty cycle \leq 2%

3. The EAS data shows Max. rating . The test condition is V_{DD} =25V, V_{GS} =10V, L=0.1mH, I_{AS}=20A

4.The power dissipation is limited by 150°C junction temperature

5. The data is theoretically the same as I_D and I_{DM} , in real applications, should be limited by total power dissipation.



Typical Characteristics

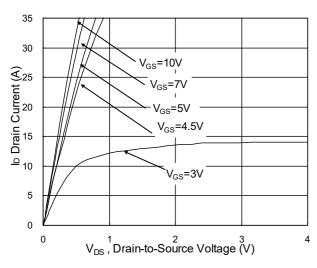


Fig.1 Typical Output Characteristics

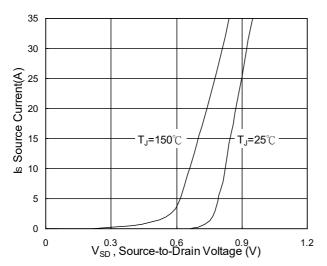


Fig.3 Forward Characteristics Of Reverse

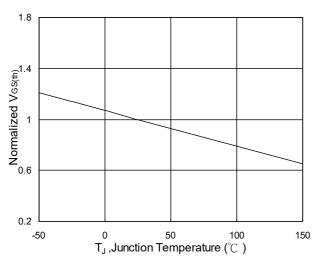


Fig.5 Normalized $V_{\text{GS}(\text{th})}$ vs. T_{J}

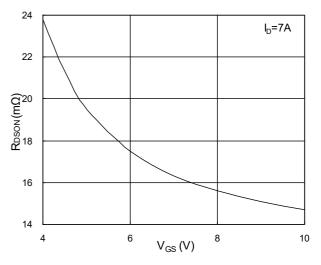


Fig.2 On-Resistance vs. Gate-Source

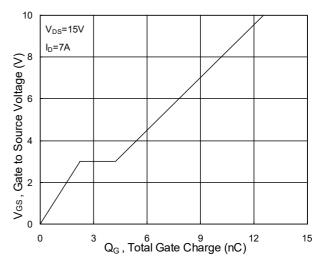


Fig.4 Gate-Charge Characteristics

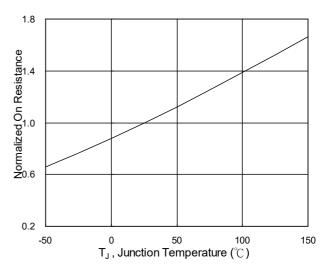


Fig.6 Normalized R_{DSON} vs. T_J



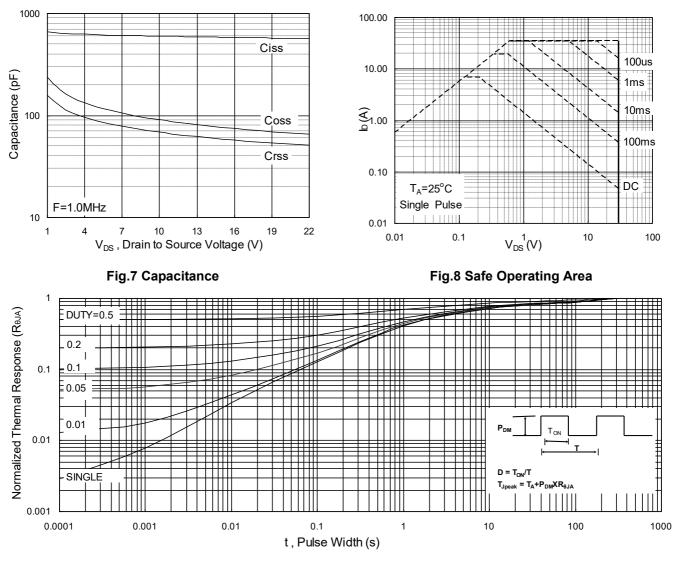


Fig.9 Normalized Maximum Transient Thermal Impedance

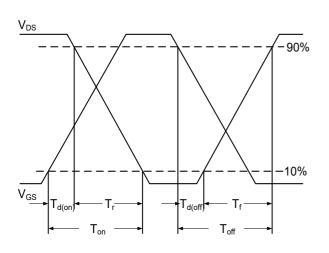


Fig.10 Switching Time Waveform

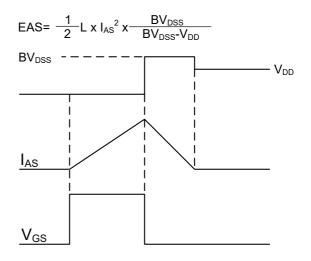
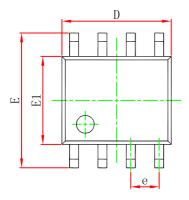
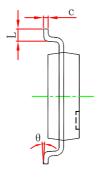


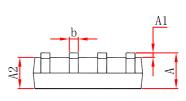
Fig.11 Unclamped Inductive Switching Waveform



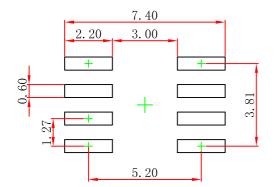
SOP-8 Package Outline Dimensions







Symbol	Dimensions In Millimeters		Dimensions In Inches		
	Min	Max	Min	Max	
Α	1.350	1.750	0.053	0.069	
A1	0.100	0.250	0.004	0.010	
A2	1.350	1.550	0.053	0.061	
b	0.330	0.510	0.013	0.020	
с	0.170	0.250	0.007	0.010	
D	4.800	5.000	0.189	0.197	
e	1.270 (BSC)		0.050 (BSC)		
E	5.800	6.200	0.228	0.244	
E1	3.800	4.000	0.150	0.157	
L	0.400	1.270	0.016	0.050	
θ	0 °	8°	0 °	8°	



Note: 1.Controlling dimension: in millimeters.

2.General tolerance:± 0.05mm.
 3.The pad layout is for reference purposes only.



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